

<b>Notice of References Cited</b>	Application/Control No. 10/667,872		Applicant(s)/Patent Under Reexamination NAKANO, TAKEHIKO	
	Examiner April Y. Shan		Art Unit 2135	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,792,113	09-2004	Ansell et al.	380/284
*	B	US-6,385,596	05-2002	Wiser et al.	705/51
*	C	US-6,327,652	12-2001	England et al.	713/2
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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